

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/893,994	PARK ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Jennifer T Nguyen	2674	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,181,317	01-2001	Taguchi et al.	345/132
	B	US-5,365,284	11-1994	Matsumoto et al.	348/793
	C	US-6,545,653	04-2003	Takahara et al.	345/87
	D	US-5,206,634	04-1993	Matsumoto et al.	340/784
	E	US-6,229,516	05-2001	Kim et al.	345/103
	F	US-5,844,538	12-1998	Shiraki et al.	345/98
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Park et al. Pub. No.: US 2002/0084964
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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